

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Smith et al.

Attorney Docket No.: KLA1P095/P1072

Application No.: 10/765,515

Examiner: Shechtman, Sean P

Filed: January 26, 2004

Group: 2125

Title: Defect Detection Using Parallel Processing

## CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as first-class mail on October 18, 2004 in an envelope addressed to the Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1440.

Signed:

Joyce L. Ferreira

## SEPARATE LETTER TO THE OFFICIAL DRAFTSMAN REQUESTING ENTERING OF FORMAL DRAWINGS (MPEP 608.02(p))

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## Dear Sir:

In response to the objections made by the Examiner, enclosed are replacement (formal) drawings for the above-identified patent application. If the Draftsman has any question concerning these drawings, he or she is respectfully requested to contact the undersigned.

Respectfully submitted,

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